

<b>Search Notes</b> 	<b>Application/Control No.</b> 09/922,945	<b>Applicant(s)/Patent under Reexamination</b> FUKASAWA, MIKIO
<b>Examiner</b> Minh Dieu Nguyen	<b>Art Unit</b> 2137	

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	5/2/2006	MDN
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	5/2/2006	MDN
Consulted with G. Barron on allowability issue	5/2/2006	MDN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
726	22	5/2/2006	MDN
709	224	5/2/2006	MDN
705	51	5/2/2006	MDN